

FORM PTO-1449 (REV. 7-80)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. : <b>WEBER, M.A. 1 PCT</b>	SERIAL NO. <b>10/534,395</b>
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT : <b>Mark A. WEBER</b>	
(Use several sheets if necessary)		FILING DATE: <b>May 10, 2005</b>	GROUP: <b>2872</b>



## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
	AL							
	AM							
	AN							
	AO							
	AP							

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

/JP/	AR		Tiziani, Hans J., and Hans-Martin Uhde, "Three-dimensional analysis by a microlens-array confocal arrangement," Applied Optics, (1994) Vol. 33, No. 4, pgs. 567-572.
	AS		

EXAMINER /Joshua Pritchett/	DATE CONSIDERED 01/22/2008
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	